

FDY100PZ

Single P-Channel (– 2.5V) Specified PowerTrench® MOSFET

General Description

This Single P-Channel MOSFET has been designed using Fairchild Semiconductor's advanced Power Trench process to optimize the $R_{\text{DS(ON)}} \textcircled{Q} \ V_{\text{GS}} = -2.5 v.$

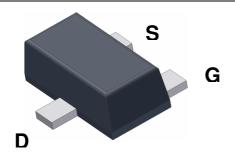
Applications

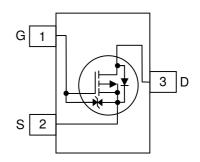
Li-Ion Battery Pack



Features

- -350 mA, -20 V $R_{DS(ON)} = 1.2$ Ω @ $V_{GS} = -4.5$ V $R_{DS(ON)} = 1.6$ Ω @ $V_{GS} = -2.5$ V
- ESD protection diode (note 3)
- RoHS Compliant





Absolute Maximum Ratings TA=25°C unless otherwise noted

| Symbol | Parameter | | Ratings | Unit s |
|------------------|--|-----------|------------------|-----------|
| V_{DSS} | Drain-Source Voltage | | -20 | V |
| V _{GSS} | Gate-Source Voltage | | ± 8 | V |
| I _D | Drain Current - Continuous | (Note 1a) | - 350 | mA |
| | – Pulsed | | – 1000 | |
| P _D | Power Dissipation (Steady State) | (Note 1a) | 625 | mW |
| | | (Note 1b) | 446 | |
| T_J, T_STG | Operating and Storage Junction Temperature Range | | -55 to +150 | °C |

Thermal Characteristics

| $R_{\theta JA}$ | Thermal Resistance, Junction-to-Ambient (Note 1a) | 200 | °C/W |
|-----------------|---|-----|------|
| Rain | Thermal Resistance, Junction-to-Ambient (Note 1b) | 280 | |

Package Marking and Ordering Information

| Device Marking | Device | Reel Size | Tape width | Quantity |
|----------------|----------|-----------|------------|------------|
| A | FDY100PZ | 7" | 8mm | 3000 units |

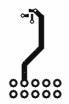
| Symbol | Parameter | Test Conditions | Min | Тур | Max | Units |
|---------------------------------------|--|---|--------|--------------------------|--------------------------|-------|
| Off Char | acteristics | | II. | I | u . | I. |
| BV _{DSS} | Drain-Source Breakdown Voltage | $V_{GS} = 0 \text{ V}, \qquad I_{D} = -250 \mu\text{A}$ | - 20 | | | V |
| ΔBV _{DSS} ΔT _J | Breakdown Voltage Temperature Coefficient | $I_D = -250 \mu A$, Referenced to 25°C | | 15 | | mV/°C |
| DSS | Zero Gate Voltage Drain Current | $V_{DS} = -16 \text{ V}, V_{GS} = 0 \text{ V}$ | | | -3 | μΑ |
| GSS | Gate-Body Leakage, | $V_{GS} = \pm 8 \text{ V}, V_{DS} = 0 \text{ V}$ | | | ± 10 | μΑ |
| On Chara | acteristics (Note 2) | | | | | |
| V _{GS(th)} | Gate Threshold Voltage | $V_{DS} = V_{GS}$, $I_D = -250 \mu A$ | - 0.65 | -1.0 | - 1.5 | V |
| $\Delta V_{GS(th)} \over \Delta T_J$ | Gate Threshold Voltage Temperature Coefficient | I_D = 250 μ A, Referenced to 25°C | | -3 | | mV/°C |
| R _{DS(on)} | Static Drain–Source On–Resistance | $\begin{array}{l} V_{GS} = -4.5 \text{ V}, \ I_D = -350 \text{ mA} \\ V_{GS} = -2.5 \text{ V}, \ I_D = -300 \text{ mA} \\ V_{GS} = -1.8 \text{ V}, \ I_D = -150 \text{ mA} \\ V_{GS} = -4.5 \text{ V}, \ I_D = -350 \text{ mA}, \\ T_J = 125^{\circ}\text{C} \end{array}$ | | 0.5 0.8 1.3 0.7 | 1.2 1.6 2.7 1.6 | Ω |
| g fs | Forward Transconductance | $V_{DS} = -5 \text{ V}, I_{D} = -350 \text{ mA}$ | | 1 | | S |
| | Characteristics | 1 1 20 0 1, 18 000 11111 | 1 | | | |
| C _{iss} | Input Capacitance | $V_{DS} = -10 \text{ V}, V_{GS} = 0 \text{ V},$ | | 100 | | pF |
| C _{oss} | Output Capacitance | f = 1.0 MHz | | 30 | | pF |
| C _{rss} | Reverse Transfer Capacitance | | | 15 | | pF |
| | g Characteristics (Note 2) | | 1 | ı | | I |
| t _{d(on)} | Turn-On Delay Time | $V_{DD} = -10 \text{ V}, I_{D} = -0.5 \text{ A},$ | | 6 | 12 | ns |
| tr | Turn-On Rise Time | $V_{GS} = -~4.5~V,~~R_{GEN} = 6~\Omega$ | | 13 | 23 | ns |
| $t_{d(off)}$ | Turn-Off Delay Time | | | 8 | 16 | ns |
| l _f | Turn-Off Fall Time | | | 1 | 2 | ns |
| Q_g | Total Gate Charge | $V_{DS} = -10 \text{ V}, I_{D} = -350 \text{ mA},$ | | 1.0 | 1.4 | nC |
| Q _{gs} | Gate-Source Charge | $V_{GS} = -4.5 \text{ V}$ | | 0.2 | | nC |
| Q_{gd} | Gate-Drain Charge | | | 0.3 | | nC |
| | ource Diode Characteristics | and Maximum Ratings | | | | |
| V_{SD} | Drain-Source Diode Forward Voltage | $V_{GS} = 0 \text{ V}, I_{S} = -150 \text{ m A}(\text{Note 2})$ | | -0.8 | -1.2 | V |
| t _{rr} | Diode Reverse Recovery Time | $I_F = -350 \text{ mA},$ | | 11 | | ns |
| Q _{rr} | Diode Reverse Recovery Charge | dI _F /dt = 100 A/μs | | 2 | | nC |

Notes:

^{1.} R_{aUA} is the sum of the junction-to-case and case-to-ambient thermal resistance where the case thermal reference is defined as the solder mounting surface of the drain pins. R_{BJC} is guaranteed by design while R_{BCA} is determined by the user's board design.



200 °C/W when mounted on a 1in² pad of 2 oz copper



- b) 280 °C/W when mounted on a minimum pad of 2 oz copper Scale 1 : 1 on letter size paper
- 2. Pulse Test: Pulse Width < $300\mu s$, Duty Cycle < 2.0%
- The diode connected between the gate and source serves only as protection againts ESD. No gate overvoltage rating is implied.

Typical Characteristics

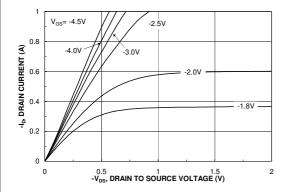


Figure 1. On-Region Characteristics.

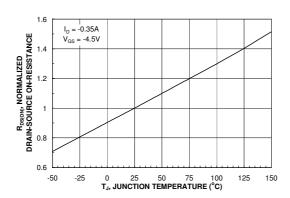


Figure 3. On-Resistance Variation with Temperature.

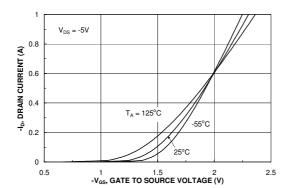


Figure 5. Transfer Characteristics.

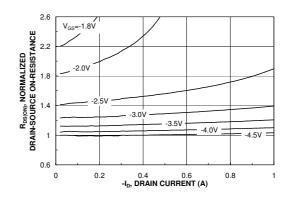


Figure 2. On-Resistance Variation with Drain Current and Gate Voltage.

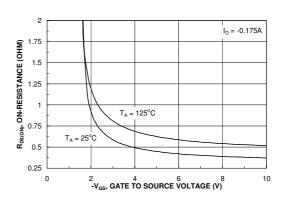


Figure 4. On-Resistance Variation with Gate-to-Source Voltage.

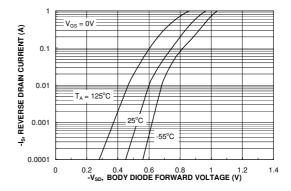


Figure 6. Body Diode Forward Voltage Variation with Source Current and Temperature.

Typical Characteristics

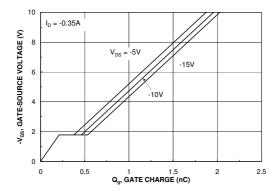


Figure 7. Gate Charge Characteristics.

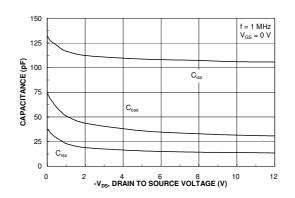


Figure 8. Capacitance Characteristics.

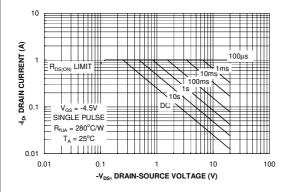


Figure 9. Maximum Safe Operating Area.

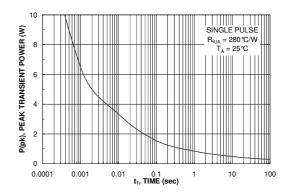


Figure 10. Single Pulse Maximum Power Dissipation.

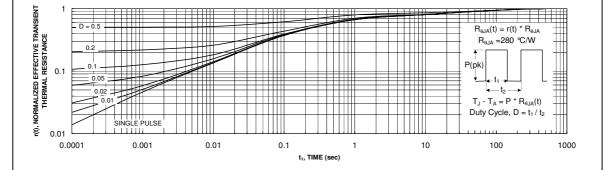
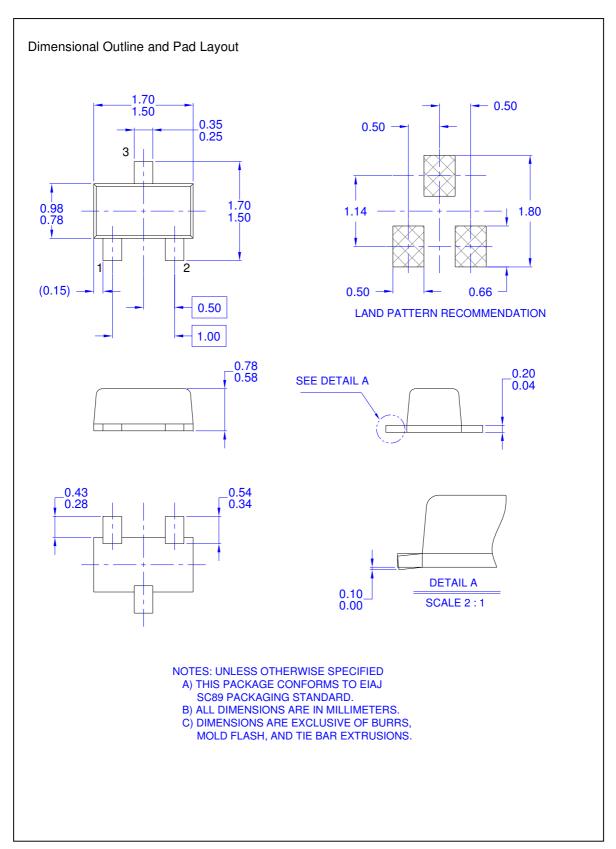


Figure 11. Transient Thermal Response Curve.

Thermal characterization performed using the conditions described in Note 1b. Transient thermal response will change depending on the circuit board design.



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